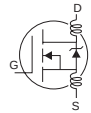


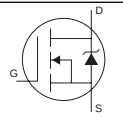
## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ.  | Max.  | Units               | Conditions                                                                   |
|---------------------------------|--------------------------------------|------|-------|-------|---------------------|------------------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 55   | —     | —     | V                   | $V_{GS} = 0V, I_D = 250\mu A$                                                |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.052 | —     | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = 1mA$                                |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —     | 0.075 | $\Omega$            | $V_{GS} = 10V, I_D = 10A$ ④                                                  |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —     | 4.0   | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                                            |
| $g_{fs}$                        | Forward Transconductance             | 4.5  | —     | —     | S                   | $V_{DS} = 25V, I_D = 10A$ ⑥                                                  |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 25    | $\mu A$             | $V_{DS} = 55V, V_{GS} = 0V$                                                  |
|                                 |                                      | —    | —     | 250   |                     | $V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$                         |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 100   | nA                  | $V_{GS} = 20V$                                                               |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -100  |                     | $V_{GS} = -20V$                                                              |
| $Q_g$                           | Total Gate Charge                    | —    | —     | 20    | nC                  | $I_D = 10A$                                                                  |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —     | 5.3   |                     | $V_{DS} = 44V$                                                               |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —     | 7.6   |                     | $V_{GS} = 10V$ , See Fig. 6 and 13 ④⑥                                        |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 4.9   | —     | ns                  | $V_{DD} = 28V$                                                               |
| $t_r$                           | Rise Time                            | —    | 34    | —     |                     | $I_D = 10A$                                                                  |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 19    | —     |                     | $R_G = 24\Omega$                                                             |
| $t_f$                           | Fall Time                            | —    | 27    | —     |                     | $R_D = 2.6\Omega$ , See Fig. 10 ④                                            |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5   | —     | nH                  | Between lead,<br>6mm (0.25in.)<br>from package<br>and center of die contact⑤ |
| $L_S$                           | Internal Source Inductance           | —    | 7.5   | —     |                     |                                                                              |
| $C_{iss}$                       | Input Capacitance                    | —    | 370   | —     | pF                  | $V_{GS} = 0V$                                                                |
| $C_{oss}$                       | Output Capacitance                   | —    | 140   | —     |                     | $V_{DS} = 25V$                                                               |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 65    | —     |                     | $f = 1.0MHz$ , See Fig. 5                                                    |



## Source-Drain Ratings and Characteristics

|          | Parameter                                 | Min.                                                                        | Typ. | Max. | Units | Conditions                                                              |
|----------|-------------------------------------------|-----------------------------------------------------------------------------|------|------|-------|-------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —                                                                           | —    | 17 ⑤ | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —                                                                           | —    | 68   |       |                                                                         |
| $V_{SD}$ | Diode Forward Voltage                     | —                                                                           | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 10A, V_{GS} = 0V$ ④                      |
| $t_{rr}$ | Reverse Recovery Time                     | —                                                                           | 56   | 83   | ns    | $T_J = 25^\circ\text{C}, I_F = 10A$                                     |
| $Q_{rr}$ | Reverse Recovery Charge                   | —                                                                           | 120  | 180  | nC    | $di/dt = 100A/\mu s$ ④⑥                                                 |
| $t_{on}$ | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |       |                                                                         |



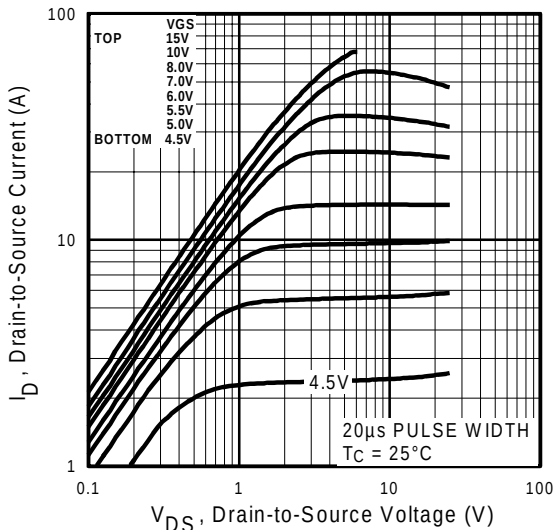
### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ②  $V_{DD} = 25V$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 1.0mH$   
 $R_G = 25\Omega$ ,  $I_{AS} = 10A$ . (See Figure 12)
- ③  $I_{SD} \leq 10A$ ,  $di/dt \leq 280A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$

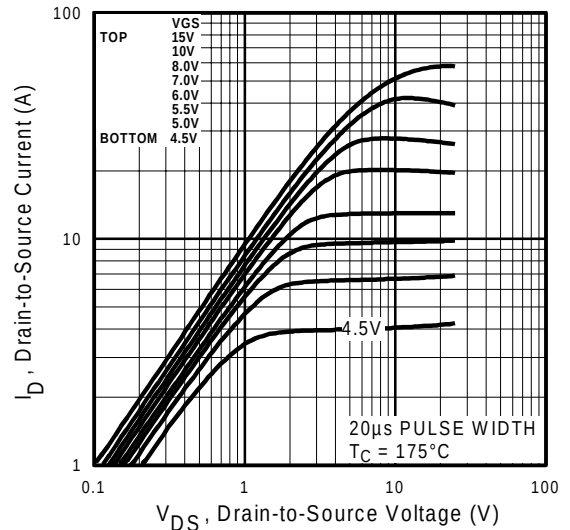
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

- ⑤ This is applied for I-PAK,  $L_S$  of D-PAK is measured between lead and center of die contact.

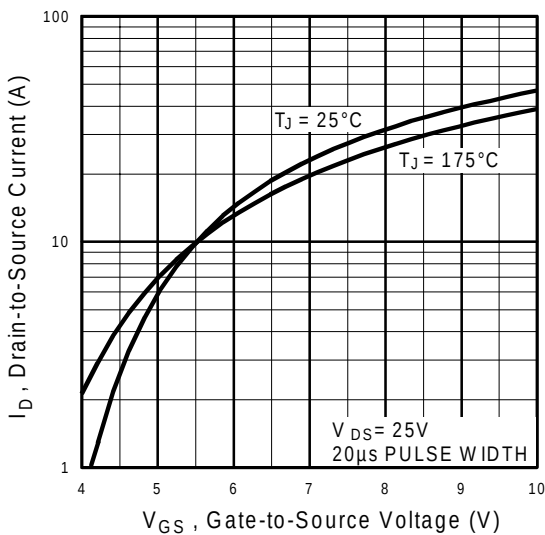
- ⑥ Uses IRFZ24N data and test conditions.



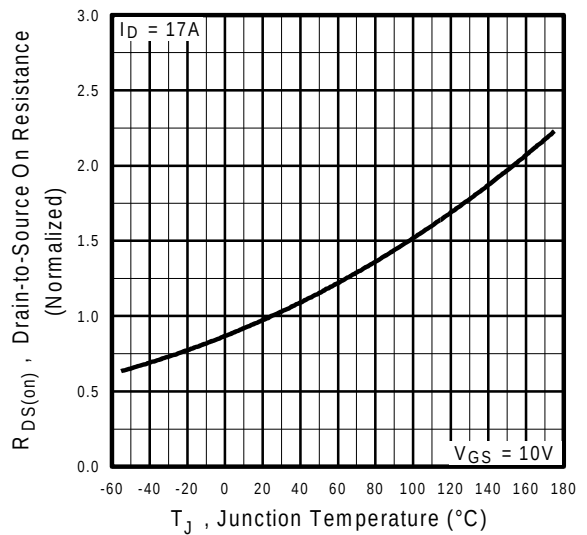
**Fig 1.** Typical Output Characteristics



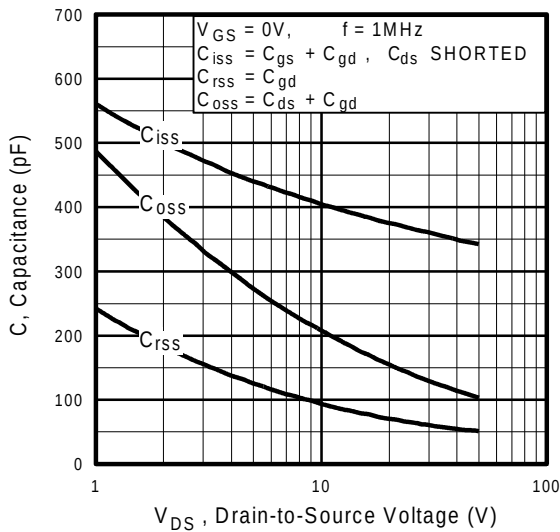
**Fig 2.** Typical Output Characteristics



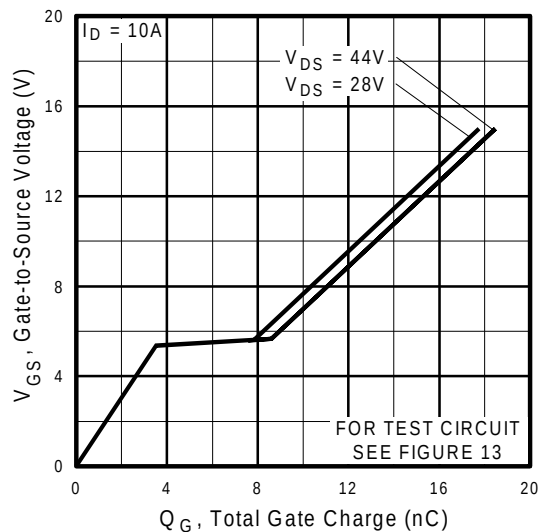
**Fig 3.** Typical Transfer Characteristics



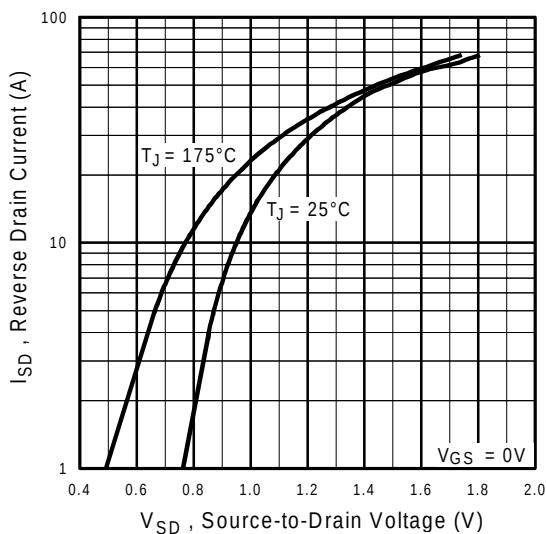
**Fig 4.** Normalized On-Resistance Vs. Temperature



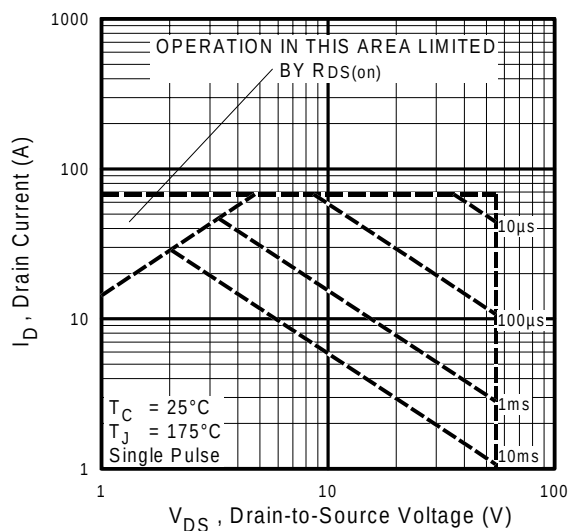
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



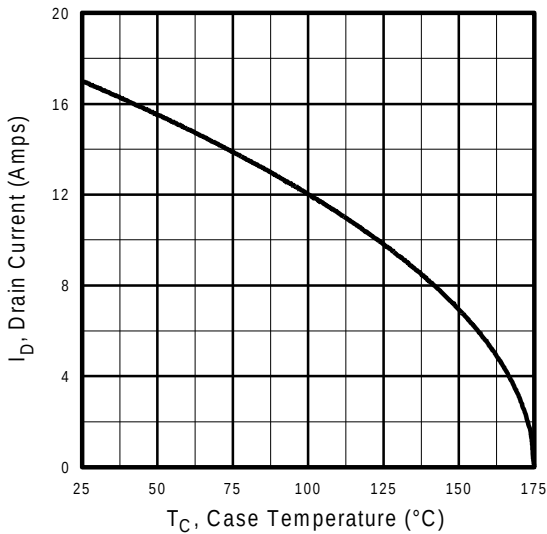
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



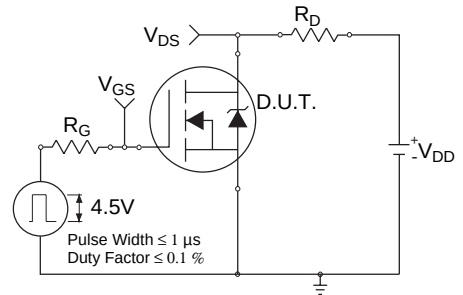
**Fig 7.** Typical Source-Drain Diode Forward Voltage



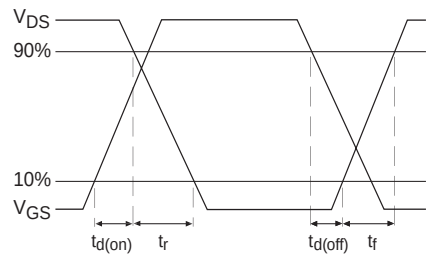
**Fig 8.** Maximum Safe Operating Area



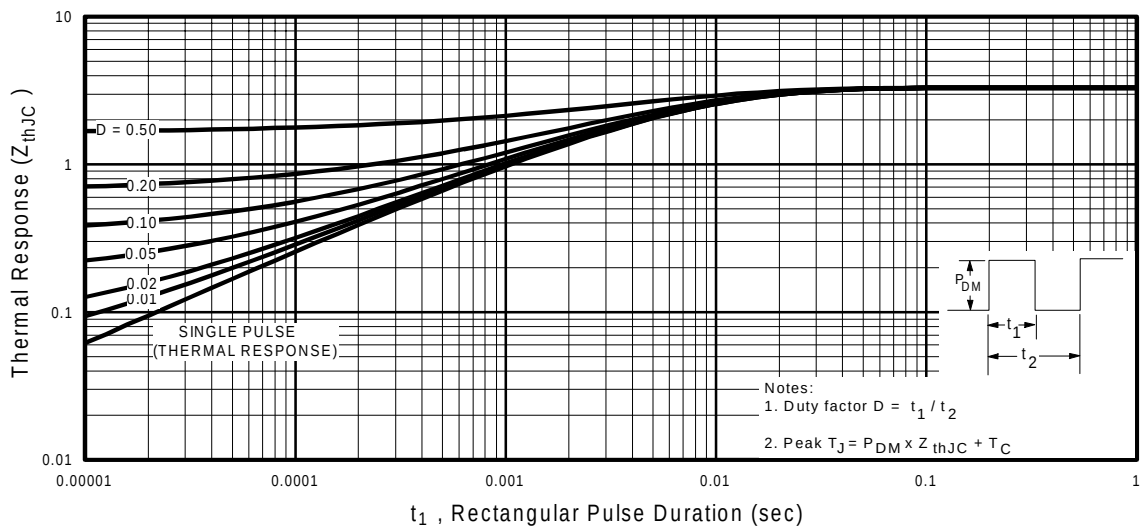
**Fig 9.** Maximum Drain Current Vs. Case Temperature



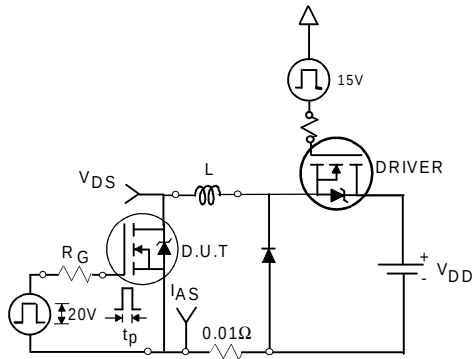
**Fig 10a.** Switching Time Test Circuit



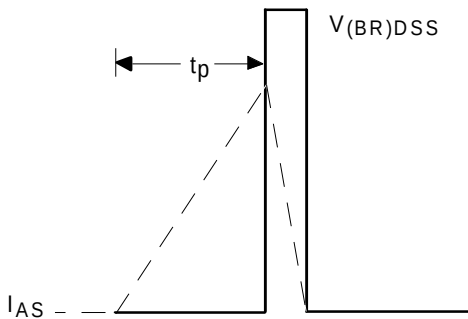
**Fig 10b.** Switching Time Waveforms



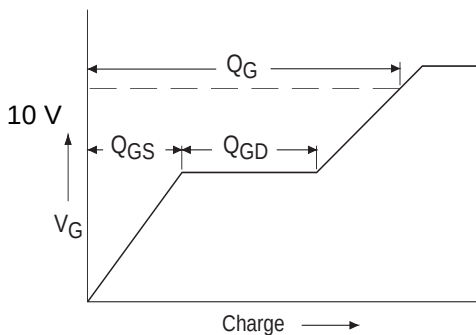
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



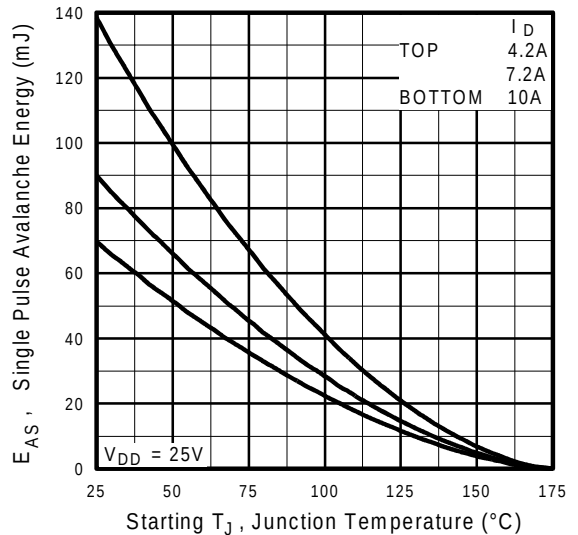
**Fig 12a.** Unclamped Inductive Test Circuit



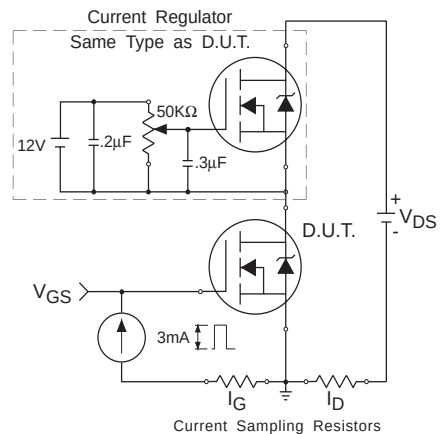
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform

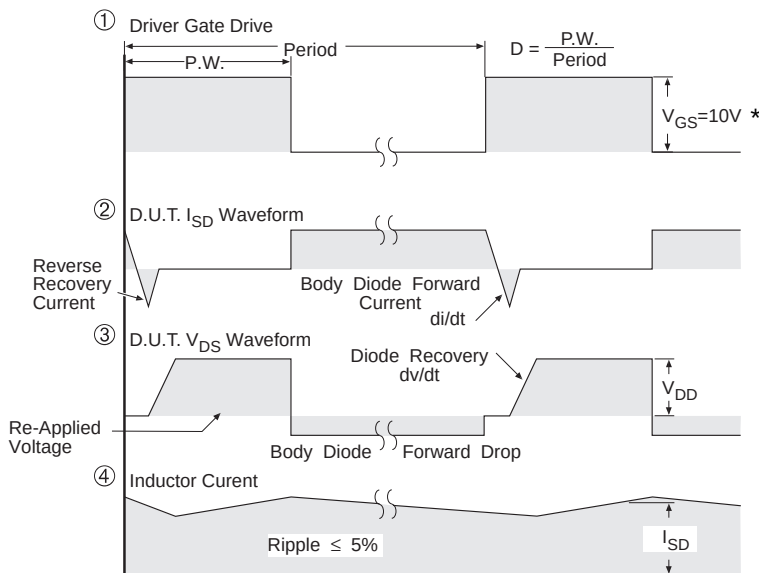
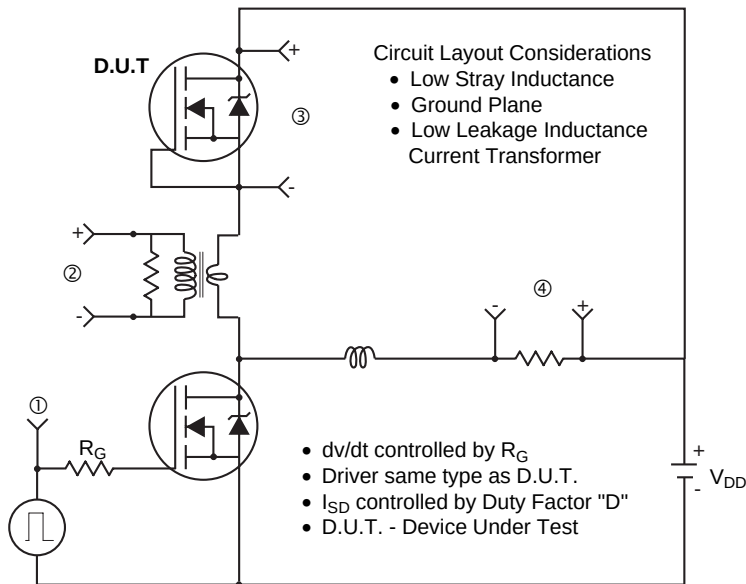


**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13b.** Gate Charge Test Circuit

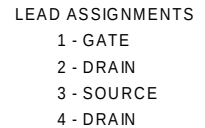
## Peak Diode Recovery dv/dt Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

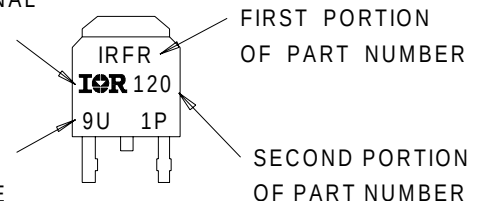
**Fig 14.** For N-Channel HEXFETS

Dimensions are shown in millimeters (inches)



## TO-252AA (D-PARK)

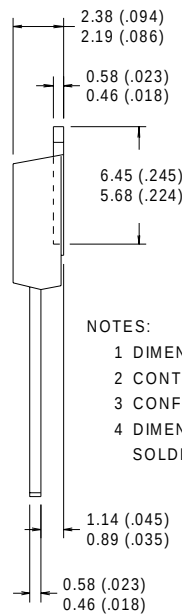
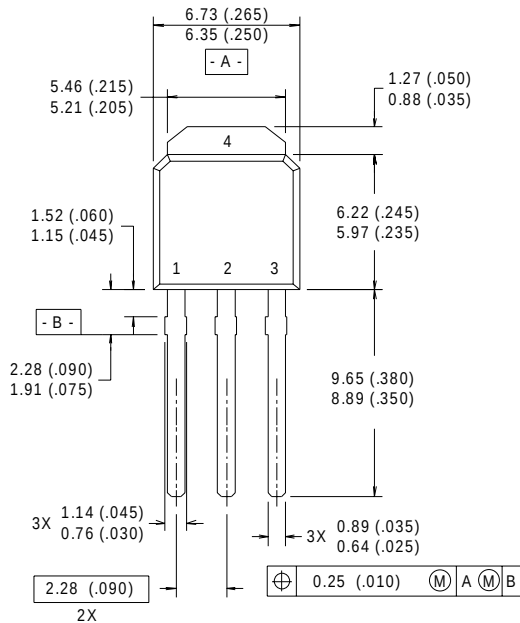
ASSEMBLY  
LOT CODE



## Package Outline

### TO-251AA Outline

Dimensions are shown in millimeters (inches)



#### LEAD ASSIGNMENTS

- 1 - GATE
- 2 - DRAIN
- 3 - SOURCE
- 4 - DRAIN

#### NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH.
- 3 CONFORMS TO JEDEC OUTLINE TO-252AA.
- 4 DIMENSIONS SHOWN ARE BEFORE SOLDER DIP, SOLDER DIP MAX. +0.16 (.006).

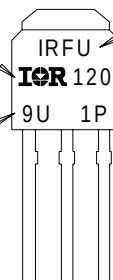
## Part Marking Information

### TO-251AA (I-PARK)

EXAMPLE : THIS IS AN IRFU120  
WITH ASSEMBLY  
LOT CODE 9U1P

INTERNATIONAL  
RECTIFIER  
LOGO

ASSEMBLY  
LOT CODE



FIRST PORTION  
OF PART NUMBER

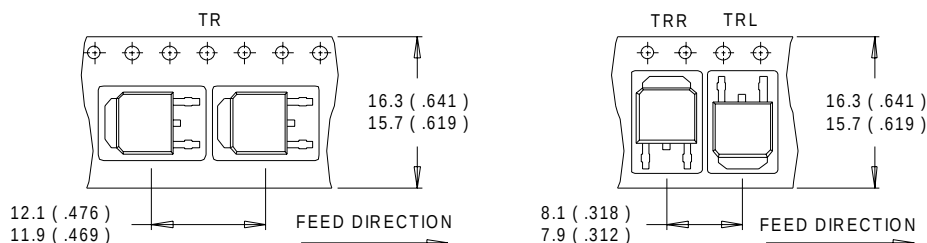
SECOND PORTION  
OF PART NUMBER



## Tape & Reel Information

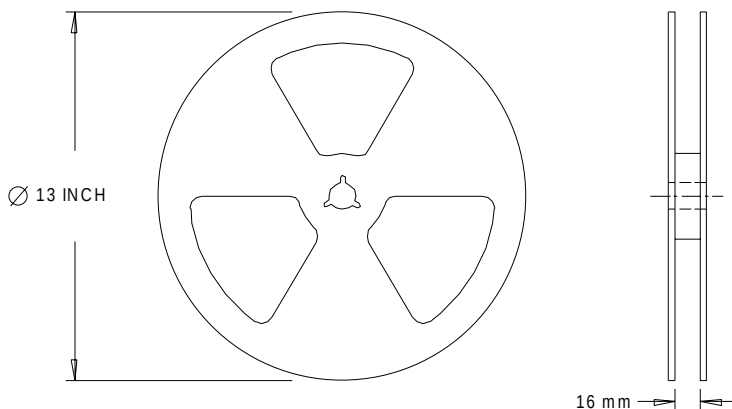
### TO-252AA

Dimensions are shown in millimeters (inches)



#### NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



#### NOTES :

1. OUTLINE CONFORMS TO EIA-481.

